

P/4303-32 (DIV)

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Patent Application of

Simon FRANK

Date: September 9, 2003

Serial No.: New Divisional Application

of USSN 10/077,668 filed February 14, 2003

Group Art Unit: 3612

Filed: Herewith

Examiner: PATEL, Kiran B.

For: VEHICLE WITH BUMPER AND DEFORMATION ELEMENT

Commissioner of Patents
P.O. Box 1450
Alexandria, VA 22313-1450

INFORMATION DISCLOSURE STATEMENT

SIR:

In compliance with the duty of disclosure under 37 C.F.R. § 1.56 and in accordance with the practice under 37 C.F.R. §§ 1.97 and 1.98, the Examiner's attention is directed to the documents listed on the enclosed Form PTO 1449. Copies of the listed foreign documents are also enclosed.

The present Information Disclosure Statement is being submitted simultaneously with the filing of the present application.

The enclosed references were cited in the parent application to the present application.

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In accordance with 37 C.F.R §§1.97(g) and (h), the filing of this Information Disclosure Statement should not be construed as a representation that a search has been made or that information cited is, or is considered to be, material to patentability as defined in §1.56(b), or that any cited document listed or attached is (or constitutes) prior art. Unless otherwise indicated, the date of publication indicated for an item is taken from the face of the item and Applicants reserve the right to prove that the date of publication is in fact different.

It is respectfully requested that the above information be considered by the Examiner and that the copy of the enclosed Form PTO-1449 be returned indicating that such information has been considered.

In the event the fee is inadvertently not enclosed or if any additional fee during the prosecution of this application is not paid, the Patent Office is authorized to charge the underpayment to Deposit Account No. 15-0700.

Respectfully submitted,



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| APPLICANT'S ART CITATION (Use several sheets if necessary) | Application | | OfGS File No. P/4303-32 |
| | Applicant Simon FRANK et al. | | |
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Examiner

Date Considered

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Sheet 1 of 1

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Filing Date: concurrently

Serial No.: n/a

Group Art:

Applicant: Simon FRANK

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